

**N-Channel Silicon Carbide MOSFET** 

Rev.02 - 24 June 2024

**Product data sheet** 

#### **1. General description**

Silicon Carbide MOSFET in a TO263-7L plastic package, designed for high frequency, high efficiency systems.



#### 2. Features and benefits

- Low on-resistance
- Fast switching speed
- 0V turn-off gate voltage for simple gate drive
- Easy to parallel
- 100% UIS Tested
- Controllable dV/dt for optimized EMI
- Reduced cooling requirements
- RoHS compliant

#### 3. Applications

- Switch Mode Power Supplies
- UPS
- Solar string inverter and solar optimizer
- EV Charger
- Motor Drives

#### 4. Quick reference data

Table 1. Q	uick reference data						
Symbol	Parameter	Conditions	Notes	s Values			Unit
Absolute	maximum rating						
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C			1700		V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 18 V; T <sub>mb</sub> = 25 °C			7.5		А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C		91			W
Tj	junction temperature			-55 to 175		5	°C
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics	·					
$R_{\text{DS(on)}}$	drain-source on-state resistance	V <sub>GS</sub> = 15 V; I <sub>D</sub> = 1 A; T <sub>j</sub> = 25 °C		-	1000	-	mΩ
Dynamic	characteristics	·					
Q <sub>G(tot)</sub>	total gate charge	$I_{D} = 2 \text{ A}; \text{ V}_{DS} = 1200 \text{ V}; \text{ V}_{GS} = 0 \text{ V}/18 \text{ V};$		-	12	-	nC
$Q_{GD}$	gate-drain charge	T <sub>j</sub> = 25 °C		-	5	-	nC
Source-d	rain diode						
Q <sub>r</sub>	recovered charge	$I_{SD}$ = 1 A; di/dt = 500 A/µs; V <sub>DS</sub> = 400 V; T <sub>j</sub> = 25 °C		-	38	-	nC

## 5. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol		
1	G	gate	mb	D		
2	SS	source sense				
3-7	S	source				
mb	D	mounting base; connected to drain	Image: Constraint of the second sec	SS sym301 S		

## 6. Ordering information

Table 3. Ordering information						
Type number	Package	Orderable part number	Packing	Small packing	Package	Package
	Name		method	quantity	version	issue date
WNSC2M1K0170B7	TO263-7L		Reel	800	TO263P-7L	12-Jun-2023

#### 7. Marking

Table 4. Marking codes						
	Type number	Marking codes				
	WNSC2M1K0170B7	WNSC2M				
		1K0170B7				

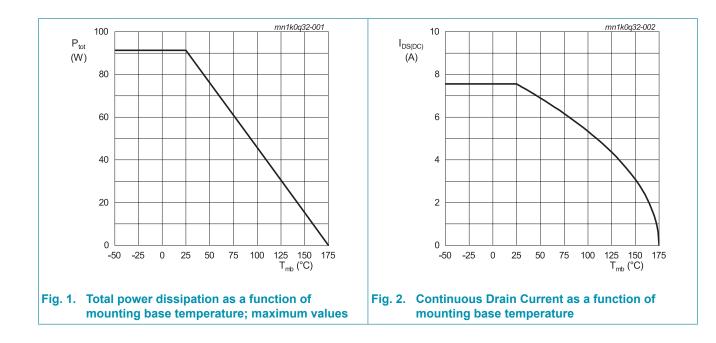
## 8. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

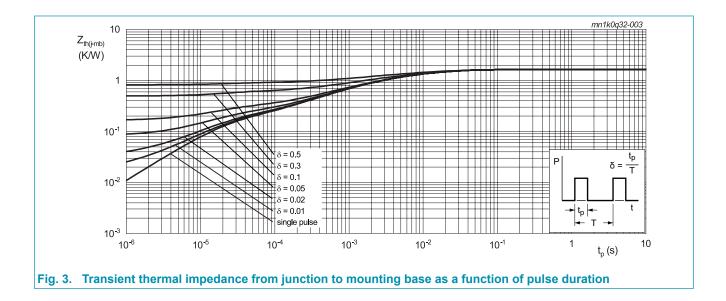
Symbol	Parameter	Conditions	Notes	Vaules	Unit
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C		1700	V
$V_{GS,max}$	gate-source voltage			-10 to 22	V
$V_{\text{GS,op}}$	gate-source voltage			-5 to 18	V
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C		91	W
I <sub>D</sub>	drain current	V <sub>GS</sub> = 18 V; T <sub>mb</sub> = 25 °C		7.5	А
		V <sub>GS</sub> = 18 V; T <sub>mb</sub> = 100 °C		5.3	А
I <sub>DM</sub>	peak drain current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$		20	А
E <sub>as</sub>	single pulse drain-to- source avalanche	$I_{AS} = 7 \text{ A}; \text{ L} = 1 \text{ mH}; \text{ V}_{DD} = 100 \text{ V};$ $T_{j(init)} = 25 \text{ °C}$		24.5	mJ
T <sub>stg</sub>	storage temperature			-55 to 175	°C
T <sub>j</sub>	junction temperature			-55 to 175	°C
$T_{sld(M)}$	peak soldering temperature			260	°C

Note: Device is ESD sensitive. Handling precautions are recommanded.



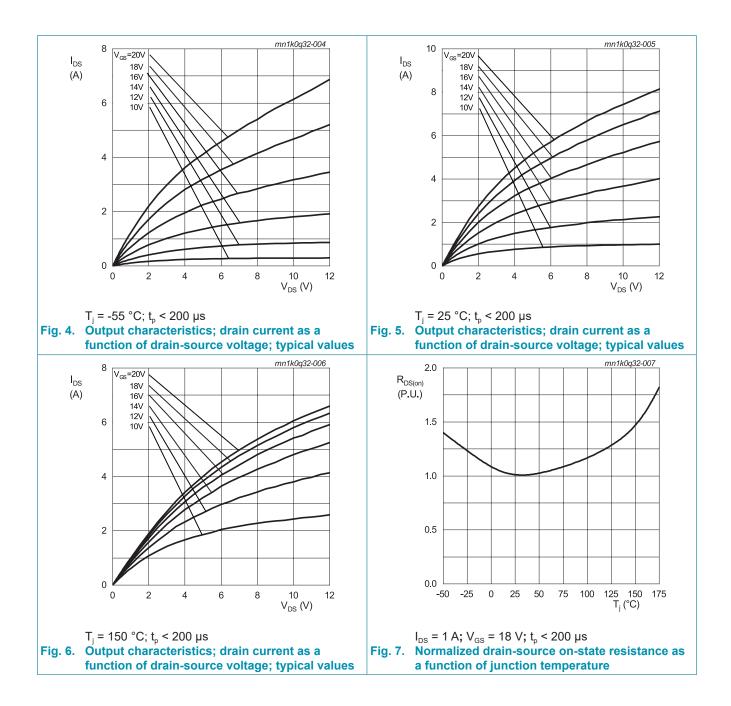
### 9. Thermal characteristics

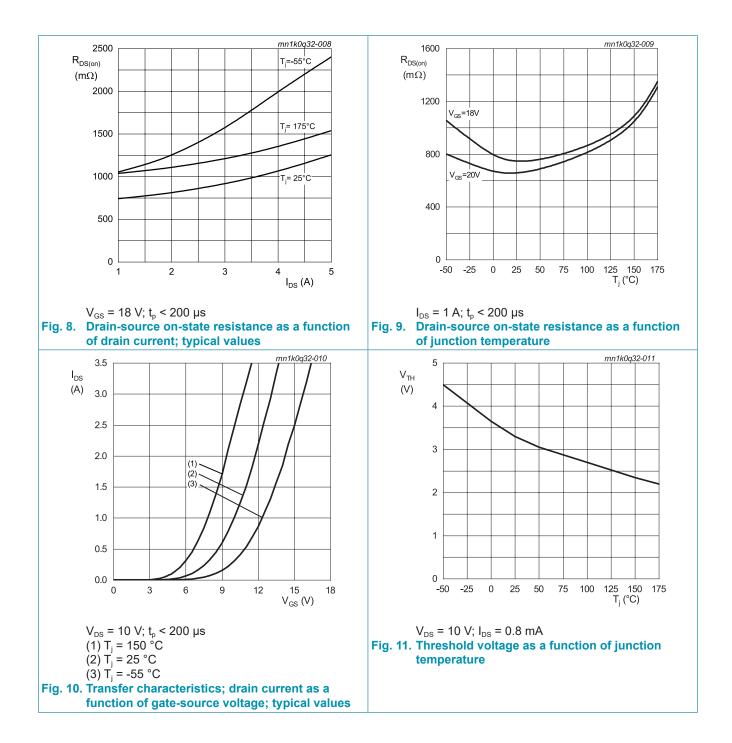
Table 6. Th	ermal characteristics						
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base			-	-	1.64	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air		-	40	-	K/W

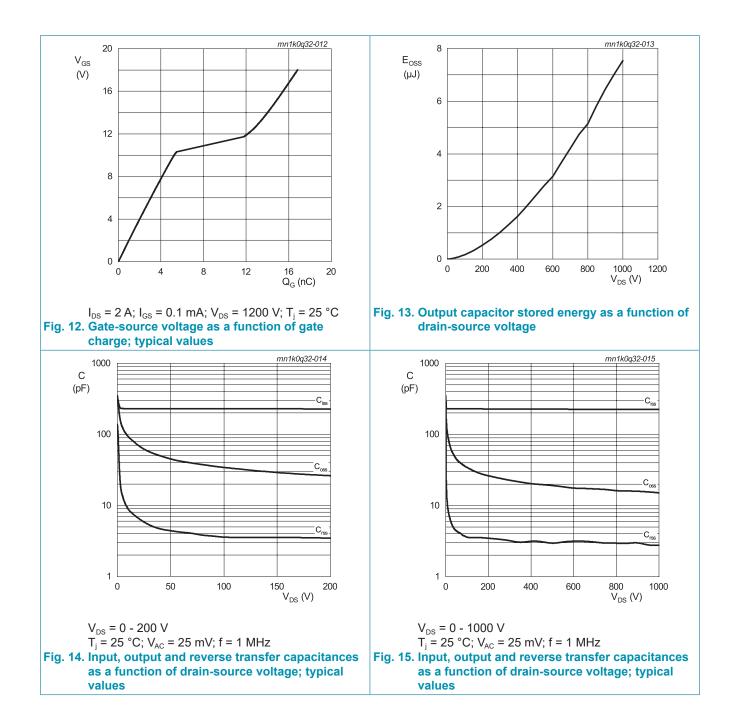


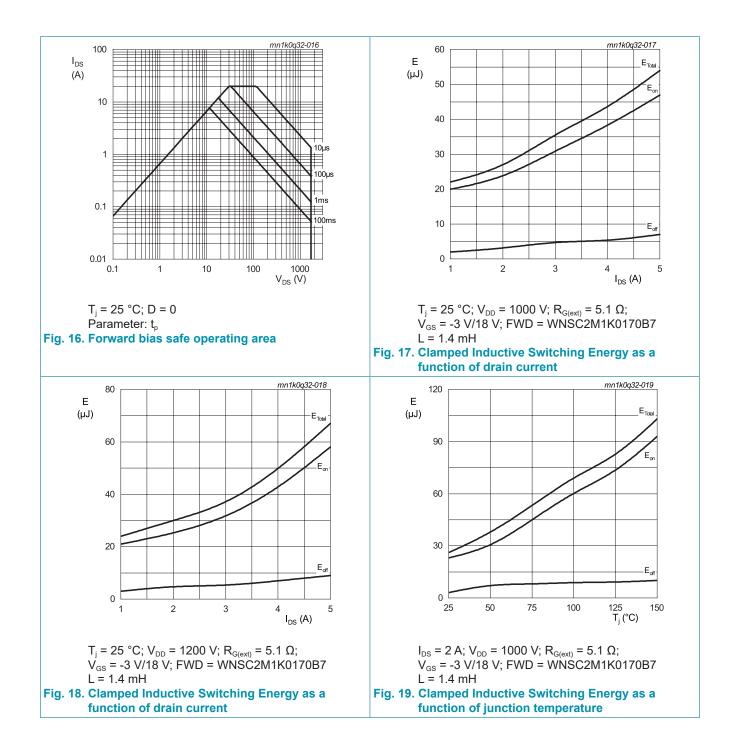
### **10. Characteristics**

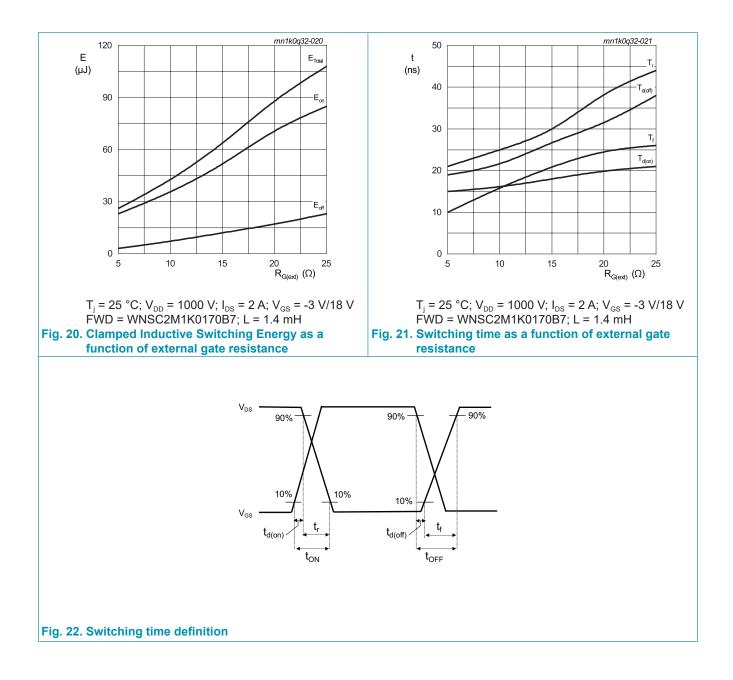
Symbol	haracteristics Parameter	Conditions	Notes	Min	Тур	Max	Unit
	aracteristics	Conditions	Notes	IVIII	קעי	INIAA	Unit
		$1 = 100 + 0.14 = 0.14 = -25 \circ 0$		1700			M
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	I <sub>D</sub> = 100 μA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C		1700	-	-	V
$V_{GS(th)}$	gate-source threshold	I <sub>D</sub> = 0.8 mA; V <sub>DS</sub> = 10 V; T <sub>j</sub> = 25 °C		2.3	3.2	4.2	V
	voltage	$I_{D}$ = 0.8 mA; $V_{DS}$ = 10 V; $T_{j}$ = 150 °C		-	2.4	-	V
I <sub>DSS</sub>	drain leakage current	$V_{DS}$ = 1700 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C		-	0.1	10	μA
		$V_{DS}$ = 1700 V; $V_{GS}$ = 0 V; $T_j$ = 150 °C		-	1	-	μA
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 18 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C		-	10	100	nA
		V <sub>GS</sub> = -10 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C		-	10	100	nA
$R_{\text{DS(on)}}$	drain-source on-state	V <sub>GS</sub> = 15 V; I <sub>D</sub> = 1 A; T <sub>j</sub> = 25 °C		-	1000	-	mΩ
	resistance	V <sub>GS</sub> = 18 V; I <sub>D</sub> = 1 A; T <sub>j</sub> = 25 °C		-	750	1200	mΩ
		V <sub>GS</sub> = 18 V; I <sub>D</sub> = 1 A; T <sub>j</sub> = 150 °C		-	1050	-	mΩ
R <sub>G</sub>	gate resistance	f = 1 MHz; T <sub>j</sub> = 25 °C		-	16	-	Ω
g <sub>fs</sub>	transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 1 A; T <sub>j</sub> = 25 °C		-	0.5	-	S
Dynamic	characteristics	1					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 2 \text{ A}; \text{ V}_{DS} = 1200 \text{ V}; \text{ V}_{GS} = 0 \text{ V}/18 \text{ V};$		-	12	-	nC
Q <sub>GS</sub>	gate-source charge	T <sub>j</sub> = 25 °C		-	3.8	-	nC
Q <sub>GD</sub>	gate-drain charge			-	5	-	nC
C <sub>iss</sub>	input capacitance	V <sub>DS</sub> = 1000 V; V <sub>GS</sub> = 0 V; f = 1 MHz;		-	225	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C		-	15	-	pF
C <sub>rss</sub>	reverse transfer capacitance			-	2.8	-	pF
E <sub>oss</sub>	Coss stored energy			-	7.5	-	μJ
t <sub>d(on)</sub>	turn-on delay time	V <sub>DS</sub> = 1000 V; V <sub>GS</sub> = -3 V/18 V;		-	15	-	ns
t <sub>r</sub>	rise time	R <sub>G(ext)</sub> = 5.1 Ω; I <sub>D</sub> = 2 A; L = 1.4 mH; T <sub>i</sub> = 25 °C		-	21	-	ns
$t_{d(off)}$	turn-off delay time	1 - 20 0		-	19	-	ns
t <sub>f</sub>	fall time			-	10	-	ns
E <sub>on</sub>	turn-on energy (Body Diode FWD)			-	23	-	μJ
$E_{off}$	turn-off energy (Body Diode FWD)			-	3	-	μJ
Source-d	rain diode						
$V_{\rm SD}$	source-drain voltage	$V_{GS}$ = 0 V; I <sub>F</sub> = 1 A; T <sub>j</sub> = 25 °C		-	3.9	-	V
		V <sub>GS</sub> = 0 V; I <sub>F</sub> = 1 A; T <sub>j</sub> = 150 °C		-	3.4	-	V
t <sub>rr</sub>	reverse recovery time	$I_{SD} = 1 \text{ A}; \text{ di/dt} = 500 \text{ A/}\mu\text{s}; V_{DS} = 400 \text{ V};$		-	36	-	ns
Q <sub>r</sub>	recovered charge	T <sub>j</sub> = 25 °C		-	38	-	nC
I <sub>rrm</sub>	reverse recovery current			-	1.8	-	А





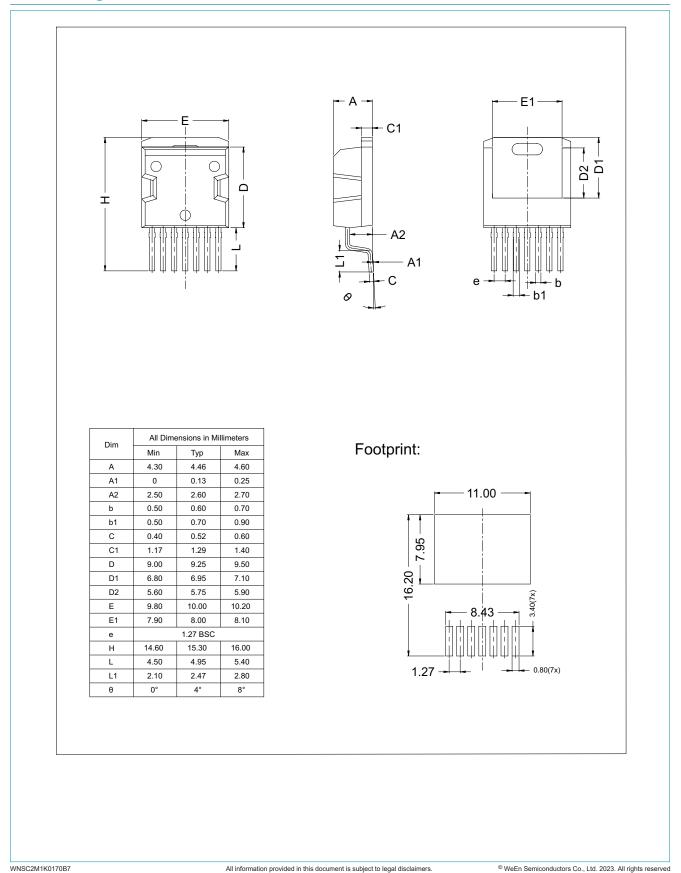






**N-Channel Silicon Carbide MOSFET** 

## 11. Package outline



#### **N-Channel Silicon Carbide MOSFET**

## 12. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions".
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